



IR MOSFET™

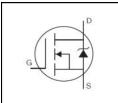
## **Features**

- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Ease of Paralleling
- Simple Drive Requirements
- Lead-Free

## **Description**

IR MOSFET™ technology from Infineon utilizes advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and rugged device design that IR MOSFET™ devices are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole.



V <sub>(BR)DSS</sub>	200V
R <sub>DS(on)</sub> max.	0.04Ω
I <sub>D</sub>	50A



G	D	S
Gate	Drain	Source

Base part number Package Type		Standard Pack		Orderable Part Number
Dase part number	Package Type	Form Quantity		Olderable Part Number
IRFP260MPbF	TO-247AD	Tube	25	IRFP260MPbF

## **Absolute Maximum Ratings**

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	50	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	35	Α
I <sub>DM</sub>	Pulsed Drain Current ①⑤	200	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	300	W
	Linear Derating Factor	2.0	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy ②⑤	560	mJ
Avalanche Current ①⑤		50	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ①	30	mJ
dv/dt	Peak Diode Recovery dv/dt③⑤	10	V/ns
$T_{\rm J}$	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case		0.50	
$R_{ heta CS}$	Case-to-Sink, Flat, Greased Surface	0.24		°C/W
$R_{ heta JA}$	Junction-to-Ambient		40	



# Electrical characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	200			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.26		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			0.04	Ω	V <sub>GS</sub> = 10V, I <sub>D</sub> = 28A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
gfs	Forward Trans conductance	27			S	V <sub>DS</sub> = 50V, I <sub>D</sub> = 28A@
ı	Drain-to-Source Leakage Current			25		$V_{DS} = 200V, V_{GS} = 0V$
IDSS	Dialii-to-Source Leakage Current			250	μΑ	$V_{DS} = 160V, V_{GS} = 0V, T_{J} = 150$ °C
	Gate-to-Source Forward Leakage			100	۰,۸	$V_{GS} = 20V$
IGSS	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -20V$

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

•	• • • • • • • • • • • • • • • • • • • •	•	•		
$Q_g$	Total Gate Charge	 	234		I <sub>D</sub> = 28A
$Q_{gs}$	Gate-to-Source Charge	 	38	nC	V <sub>DS</sub> = 160V
$Q_{gd}$	Gate-to-Drain Charge	 	110		V <sub>GS</sub> = 10V, See Fig.6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	17			V <sub>DD</sub> = 100V
t <sub>r</sub>	Rise Time	60			$I_D = 28A$
$t_{d(off)}$	Turn-Off Delay Time	 55		ns	$R_G = 1.8\Omega$
t <sub>f</sub>	Fall Time	 48			V <sub>GS</sub> = 10V, See Fig.10⊕
L <sub>D</sub>	Internal Drain Inductance	 5.0		ъЦ	Between lead, 6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance	 13		nH	from package and center of die contact
C <sub>iss</sub>	Input Capacitance	 4057			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance	 603		pF	$V_{DS} = 25V$
$C_{rss}$	Reverse Transfer Capacitance	 161			f = 1.0MHz, See Fig.5

### **Diode Characteristics**

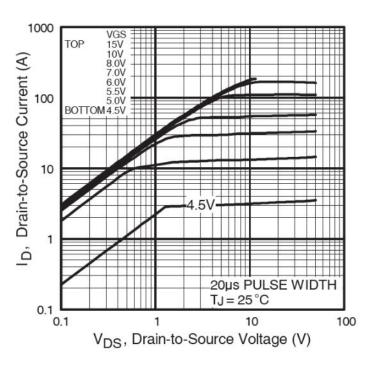
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	Parameter	Min.	Typ.	wax.	Units	Conditions
Is	Continuous Source Current (Body Diode)			50		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current			200		integral reverse
- OW	(Body Diode) ①					p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 28A, V_{GS} = 0V $ ④
t <sub>rr</sub>	Reverse Recovery Time		268	402	ns	$T_J = 25^{\circ}C$ , $I_F = 28A$
$Q_{rr}$	Reverse Recovery Charge		1.9	2.8	μC	di/dt = 100A/µs ④

#### **Notes**

- $\, \mathbb{O} \,$  Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Starting  $T_J$  = 25°C, L = 1.5mH,  $R_G$  = 25 $\Omega$ ,  $I_{AS}$  = 28A.(See fig. 12).
- $\label{eq:local_local_local_local} \mbox{$\Im$} \quad I_{SD} \leq 28A, \ di/dt \leq 486A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- 4 Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .

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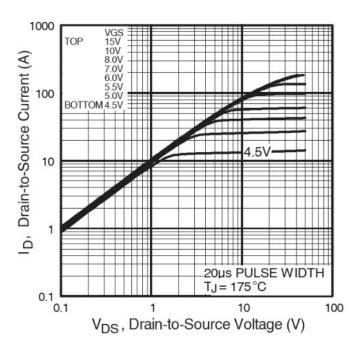
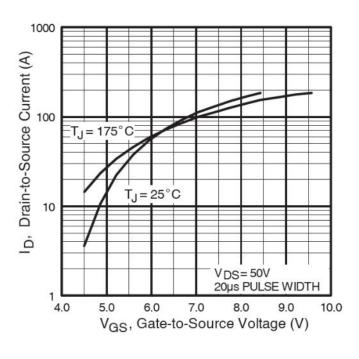


Fig. 1 Typical Output Characteristics

Fig. 2 Typical Output Characteristics



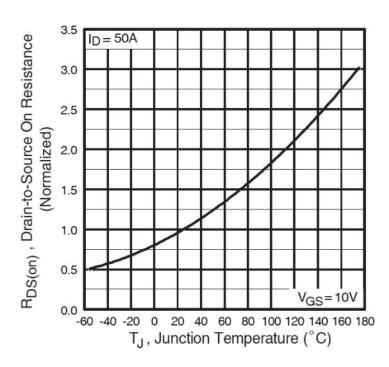
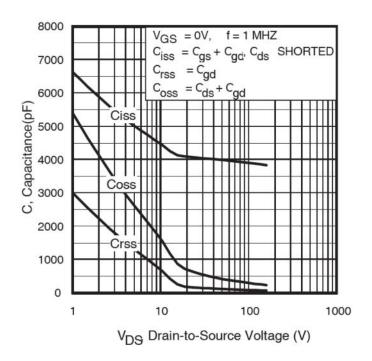
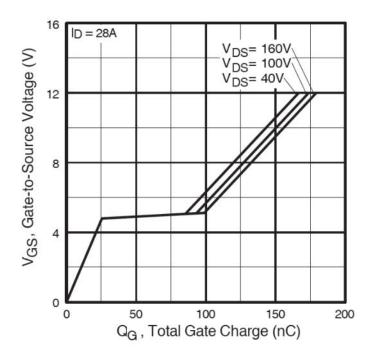


Fig. 3 Typical Transfer Characteristics

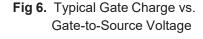
Fig. 4 Normalized On-Resistance vs. Temperature

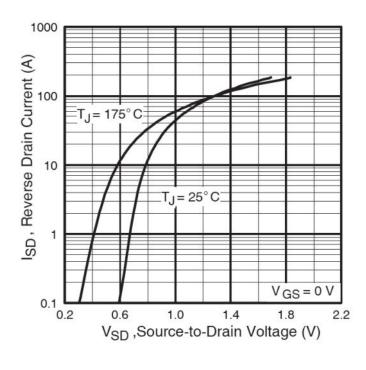






**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage







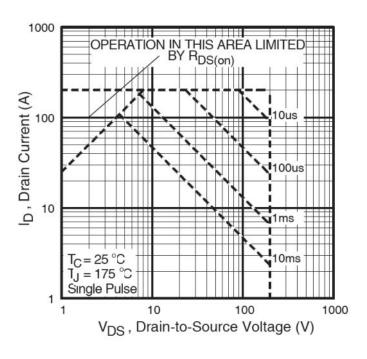
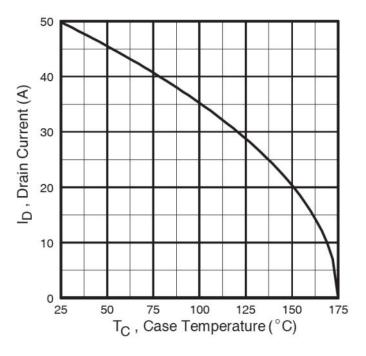


Fig 8. Maximum Safe Operating Area

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**Fig 9.** Maximum Drain Current vs. Case Temperature

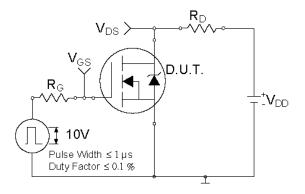


Fig 10a. Switching Time Test Circuit

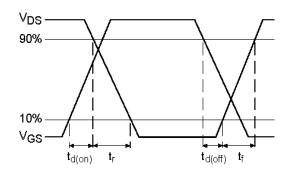


Fig 10a. Switching Time Waveforms

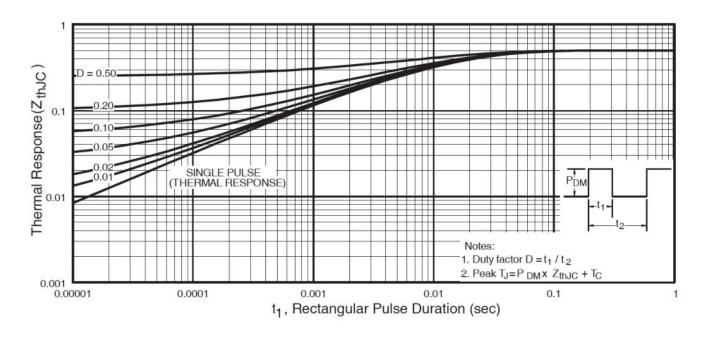


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



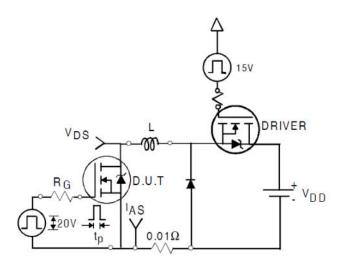


Fig. 12a. Unclamped Inductive Test Circuit

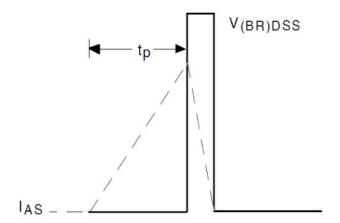


Fig. 12b. Unclamped Inductive Waveforms

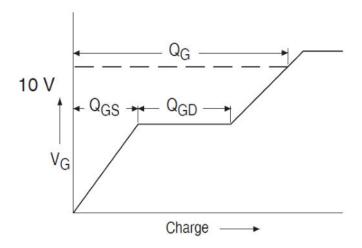
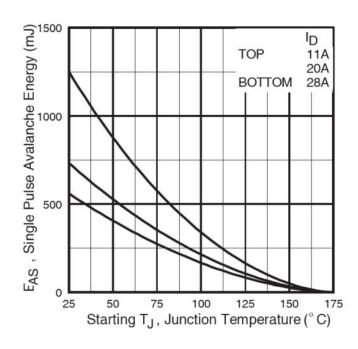


Fig 13a. Basic Gate Charge Waveform



**Fig 12c.** Maximum Avalanche Energy vs. Drain Current

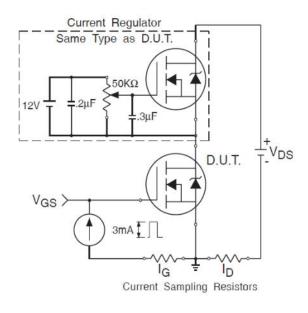
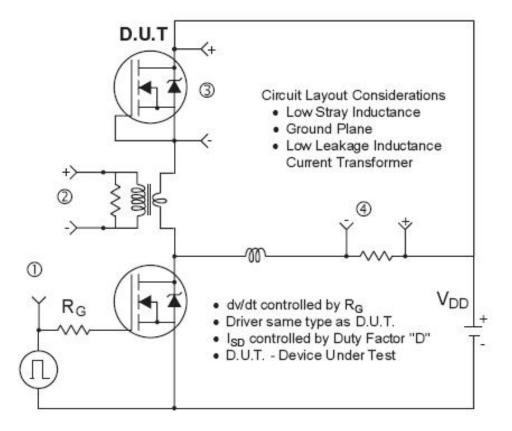


Fig 13b. Gate Charge Test Circuit





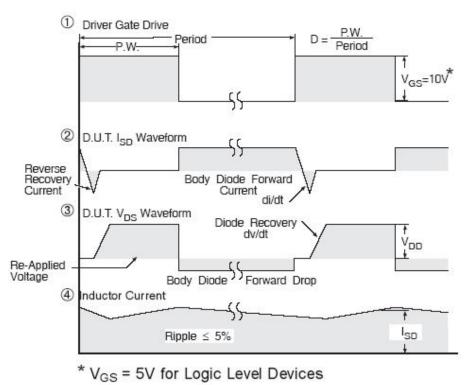
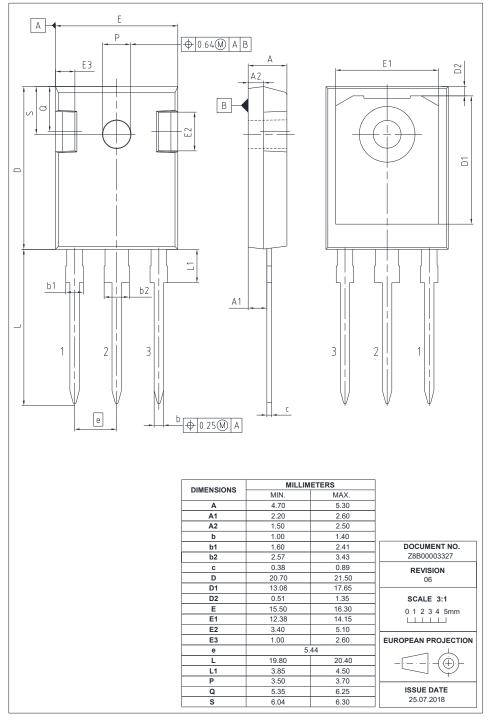


Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel IR MOSFET™

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## TO-247AD Package Outline (Dimensions are shown in millimeters (inches))



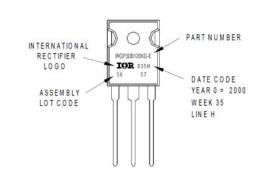
## **TO-247AD Part Marking Information**

EXAMPLE: THIS IS AN IRGP30B120KD-E WITH ASSEMBLY

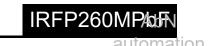
LOT CODE 5657

ASSEMBLED ON WW 35, 2000 IN THE ASSEMBLY LINE "H"

Note: "P" in assembly line position indicates "Lead-Free"







## **Revision History**

Date	Comments			
	Updated datasheet with corporate template			
05/28/2020	Updated Package picture-page1			
03/26/2020	Corrected from "Hexfet power MOSFET" to " IR MOSFET™" -page1 &7			
	Corrected part marking from TO-247AC to TO-247AD on page 8.			

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